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Yasuhiro HIBINO et al.FILING DATE
March 1, 2005

GROUP

2821

Examiner
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U.S. PATENT DOCUMENTS

| *EXAMINER INITIAL | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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FOREIGN PATENT DOCUMENTS

| | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION NO YES |
|------|-----------------|-----------|--------------------|-------|----------|--------------------|
| T.H. | 2002-9505 | 1/11/02 | Japan (w/Abstract) | — | — | X |
| | 10-126220 | 5/15/98 | Japan (w/Abstract) | — | — | X |
| | 09-130285 | 5/16/97 | Japan (w/Abstract) | — | — | X |
| | 07-162251 | 6/23/95 | Japan (w/Abstract) | — | — | X |
| | 52-111507 | 8/24/77 | Japan (w/Abstract) | — | — | X |
| | 2003-198309 | 7/11/2003 | Japan (w/Abstract) | — | — | X |
| | 59-140552 | 9/19/84 | Japan (w/Abstract) | — | — | X |
| | 08-112857 | 4/22/94 | Japan (w/Abstract) | — | — | X |
| | 2002-064401 | 2/28/2002 | Japan (w/Abstract) | — | — | X |
| | 2002-208875 | 7/2/2002 | Japan (w/Abstract) | — | — | X |
| | WO00/13315 | 3/9/2000 | WIPO | — | — | X |
| T.H. | 2003-188952 | 7/4/2003 | Japan (w/Abstract) | — | — | X |
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

Tan Ho

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